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Design and development of a coaxial cryogenic probe for precision measurements of the quantum Hall effect in the AC regime

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ABSTRACT
The quantum Hall effect is the basis for the realisation of the resistance and impedance units in the International System of units since 2019. This paper describes a cryogenic probe that allows to set graphene Hall devices in quantisation conditions in a helium bath (4.2 K) and magnetic fields up to 6 T, to perform precision measurements in the AC regime with impedance bridges. The probe has a full coaxial wiring, isolated from the probe structure, and holds the device in a TO-8 socket. First, characterization experiments are reported on a GaAs device, showing quantisation at 5.5 T. In the AC regime, multiple-series connections will be employed to minimize the residual error, quantified by electrical modelling of the probe.

1. INTRODUCTION
In the revised International System of Units (SI) the units of electrical impedance (ohm, Henry, Farad) can be realised from the quantised Hall resistance \( R_H = \frac{h}{e^2} \), where \( h = 6.62607015 \times 10^{-34} \text{ Js} \) and \( e = 1.602176634 \times 10^{-19} \text{ C} \), is the von Klitzing constant, is an exact value [1] and \( i \) is a small integer (typically, \( i = 2 \)). The aim of the project GIQS: Graphene Impedance Quantum Standard (see Acknowledgments) is to develop and make available an affordable and easy-to-operate impedance standard exploiting the quantum Hall effect (QHE) in graphene.

Graphene devices are of strong interest for the realisation of electrical units since they display the QHE at lower magnetic fields (below 5 T) and higher temperatures (several K) than semiconductor devices, such as the well-established GaAs ones [2]–[5]. The operating conditions can thus be achieved with simpler and less expensive cryogenic systems. Nevertheless, the direct measurement of the quantised resistance in the AC regime requires careful considerations about device wiring and shielding [6]–[8], to minimise the effects of stray parameters which can alter the apparent resistance of the device from the quantised value [7].

To date, the direct traceability of capacitance to the QHE has been implemented with a coaxial transformer quadrature bridge, using two independent QHE devices in a twin probe [9]–[11]. The development of high-accuracy digital impedance bridges [12], [13] opens the possibility for simplified implementations. Among the goals of the GIQS project is the development of
impedance standards based on electronic fully-digital impedance bridges [8], [14]-[16] associated to individual QHE devices operating in a simple cryogenic environment.

The following describes the realisation of a cryogenic environment for QHE devices, which includes a coaxial cryogenic probe and a superconducting magnet of small size. The environment is suitable to perform QHE experiments at liquid helium temperature of 4.2 K, and for an applied magnetic induction up to 6 T, adequate for graphene QHE devices.

The probe will be employed with a new fully-digital coaxial impedance bridge developed in [16]. The bridge is optimised to perform QHE experiments at liquid helium temperature of 4.2 K, and for an applied magnetic induction up to 6 T, adequate for graphene QHE devices.

The probe frame was fabricated by Graphensic AB, Sweden, according to INRIM specifications.

Figure 1. A computer rendering of the cryomagnetic probe assembly: (left) side view; (right) front view, showing the magnet bore.

Figure 2. The probe cryomagnet, showing the yellow winding insulation. A header (white) was added to ease the insertion in the cryostat.

In the following, the probe is described and tested in the DC regime, using a novel GaAs sample that shows quantization plateaus for a magnetic induction (5.5 T for the $i = 2$ plateau) lower than typical devices employed in metrology [7]. The results of the measurement are reported.

When employed in the AC regime, the parasitic parameters of the device, the sample holder and the probe will shift the apparent resistance, measured at the end of the coaxial wiring, with respect to the quantized value. The minimization of this shift with the implementation of the multiple-series connection scheme is discussed.

2. THE PROBE

A simplified diagram of the probe assembly\(^1\) is shown in Figure 1. The small size of the probe allows the insertion in a standard dewar having a 50 mm port, such as transport dewars.

2.1. Superconducting magnet

The probe supports a superconducting magnet (see Figure 2) that can reach a field up to 6 T at 4.2 K when energized with a DC current of approximately 65 A. The field homogeneity is 0.1% over a 10 mm length. The magnet includes a superconducting thermal switch, which allows its operation in persistent mode.

2.2. Probe insert

The probe holds a sliding insert. The bottom side of the insert (Figure 3), which enters the magnet bore, mounts a TO-8 socket connected with nine coaxial wires\(^2\). Of these nine wires, eight are intended to be used on the current and voltage terminals of the device; the 9th wire is available for driving a section of the double shield (see below).

Samples can be mounted on special TO-8 sample holders (Figure 4) implementing a double-shielding technique [17] that minimises the frequency dependence of the quantised Hall resistance caused by unwanted stray capacitances. The socket is wired with the inner conductors of the coaxial cables; the outer conductors are connected to a common node very close to the sample holder.

The coaxial wiring (Figure 5) is terminated on a connection box at the top of the insert (Figure 6) with isolated British Post

\(^1\) The probe frame was fabricated by Graphensic AB, Sweden, according to INRIM specifications.

\(^2\) Lakeshore Ultra Miniature Coaxial Cable, type SC, Teflon insulation. The wire has an outer diameter of 1 mm; the inner conductor has a series resistance per unit length of 0.282 $\Omega$ m$^{-1}$ at room temperature; the inner to outer capacitance per unit length is 154 pF m$^{-1}$. 

2 Lakeshore Ultra Miniature Coaxial Cable, type SC, Teflon insulation. The wire has an outer diameter of 1 mm; the inner conductor has a series resistance per unit length of 0.282 $\Omega$ m$^{-1}$ at room temperature; the inner to outer capacitance per unit length is 154 pF m$^{-1}$. 

...
Office Multiple Unit Steerable Array (BPO MUSA) coaxial connectors. Often employed in impedance metrology, BPO-MUSA connectors exhibit a good performance also in the DC regime. The whole coaxial network composed of the device and the wiring is completely isolated from the probe.

2.3. Operation

Figure 7 shows the probe in operation. It is inserted into a 60 L liquid helium dewar. The magnet is energised with a DC high-current power supply (Cryogenics PS 120A). A manual current-reversing switch allows to reverse the magnetic field polarity.

The superconducting switch in parallel with the magnet is driven by a DC laboratory power supply, which is turned off to activate the persistent mode of operation. The persistent mode maximises field stability and minimizes helium consumption, since the magnet wires are unloaded, and can be used when performing precision measurements on a QHE plateau.

3. TESTING

A test of the probe was made by performing measurement in the DC regime on a GaAs sample.

3.1. GaAs sample

The investigated sample, P151-24, was fabricated at the Physikalisch-Technische Bundesanstalt (PTB) facilities. Details of the process can be found in [18].

P151 is a 500 µm semi-insulating GaAs wafer on which a GaAs-AlGaAs heterostructure was grown by Molecular Beam Epitaxy (MBE). The wafer was cleaved in rectangles of 7 mm × 3 mm, and 8 contacts (two current and six voltage contacts) were made by tin ball annealing. The contacts have a resistance of about 10 mΩ.

P151 samples achieve a mobility of 58.5 T⁻¹ and a carrier concentration in the two-dimensional electron gas \(n = 2.67 \times 10^{-15} \text{m}^{-2}\). This concentration corresponds to a \(i = 2\) quantum Hall plateau at the magnetic induction \(B = \frac{nh}{ie} = 5.5\) T, where \(h\) is the Planck constant and \(e\) the electron charge. Such magnetic induction can be compared with the typical induction required by ubiquitous LEP samples [19],
of about 9 T. Tests at \( T = 2.2 \, \text{K} \) and \( I = 39 \, \mu\text{A} \) show full quantization to parts in \( 10^9 \), and a critical current density of \( 6 \times 10^2 \, \text{A m}^{-1} \) (30 \( \mu\text{A} \) over 0.5 mm) at \( T = 1.2 \, \text{K} \) [18]. At \( T = 4.2 \, \text{K} \), \( I = 77 \, \mu\text{A} \), the relative deviation from the exact quantization is about \( -0.6 \times 10^{-6} \).

The sample is mounted on an unshielded TO-8 holder with soldered Pt wires.

### 3.2. Measurements

The device is driven by a purpose-built, isolated and battery-operated DC current source. The source can be manually operated to deliver the current values \( I = 0 \, \mu\text{A}, \pm 5 \, \mu\text{A}, \pm 20 \, \mu\text{A}, \pm 50 \, \mu\text{A} \) and \( \pm 100 \, \mu\text{A} \), and includes a fast protection circuit in case of device thermal runaway. The DC voltage on selected contacts is measured with a two-channel nanovoltmeter (Agilent 34420A).

Figure 8 reports the outcome of the experiment. Figure 8(a) is the graph of the Hall resistance \( R_H(B) \) versus the applied magnetic field \( B \), measured with a current \( I = 20 \, \mu\text{A} \). Figure 8(b) shows the corresponding longitudinal resistance \( R_{xx}(B) \). Curves obtained with increasing and decreasing \( B \) are shown; a little hysteresis, related to the sweep rate (about 0.6 T min\(^{-1}\)) can be appreciated. Increasing the current up to \( I = 50 \, \mu\text{A} \) leads to similar results (not reported).

In Figure 8(a) quantum Hall plateaux corresponding to filling factors \( \nu = 2 \) and \( \nu = 4 \) can be easily identified, and higher-index plateaux can be appreciated. Figure 8(b) shows the corresponding Shubnikov-de Haas oscillations. On the \( \nu = 2 \) plateau, \( R_H \) is flat over a range of about 0.2 T; the corresponding \( R_{xx} \) is lower than 50 mΩ. The outcome of the experiment is consistent with the expectations on a GaAs device.

### 4. AC QUANTUM HALL EFFECT

In the DC regime the quantum Hall resistance is defined as a four-terminal (4T) resistance [20]. If the 4T definition is applied (no current is drawn from the voltage terminals by the measurement setup) the cable errors are due to the wiring parasitic conductances, which can be made negligible with adequate isolation.

In the AC regime, the four terminal-pair (4TP) impedance standard definition is the most accurate [20, 21]. 4TP impedance definition is however impractical for the quantum Hall resistance. Since the output impedance of the voltage terminals of a QHE device is of the order of \( R_H \), the parasitic admittances of the cables give rise to very large errors at both the current and the voltage terminal-pairs. Attempts to solve the problem by triaxial connections and active guards were not completely successful [22].

The peculiarity of the quantized Hall state as a circuit element [23] allows to exploit the so-called multiple-series connections [24]. Such connections redefine the quantum Hall resistance as a two-terminal resistance (in the DC regime) or a two terminal-pair (2TP) impedance (in AC) by keeping the magnitude of the cable connection errors to very low values.

In the DC regime, the behaviour of multiple-series connections has been extensively considered [24], and dedicated modelling tools for the electrical analysis of the connections are available [25]-[27].

In the AC regime, multiple-series connections have been also implemented, although in a limited number of setups [3, 6-8]. The connections schematics are shown in Figure 9. For the case \( n = 1 \), no multiple-series schematic is employed, and the device is simply connected as a 2TP impedance with two coaxial leads.

![Figure 7](image7.png)

**Figure 7.** Overall view of the measurement setup for DC characterization. On the left, the liquid helium dewar, with the coaxial probe inserted. On the right, the rack of electronic instrumentation.

![Figure 8](image8.png)

**Figure 8.** Plot of the measured values of \( R_H \) and \( R_{xx} \) versus the magnetic field \( B \), for an applied current \( I = 20 \, \mu\text{A} \). Blue line: increasing magnetic field. Red line: decreasing magnetic field.
Table 1. Calculation of the real part of the relative error δZ\text{r} occurring when measuring a QHE device by using the n-series connections given in Figure 9, for the frequency f = 1541 Hz. The calculation is given for two different contact resistance values.

<table>
<thead>
<tr>
<th>Re[δZ\text{r}]</th>
<th>n</th>
<th>Rc = 10 mΩ</th>
<th>Rc = 10 Ω</th>
</tr>
</thead>
<tbody>
<tr>
<td>1</td>
<td></td>
<td>+1.0 × 10⁻⁴</td>
<td>+1.7 × 10⁻¹</td>
</tr>
<tr>
<td>2</td>
<td></td>
<td>-5.6 × 10⁻⁹</td>
<td>+1.4 × 10⁻⁴</td>
</tr>
<tr>
<td>3</td>
<td></td>
<td>-1.1 × 10⁻⁹</td>
<td>-9.5 × 10⁻⁴</td>
</tr>
</tbody>
</table>

The case n = 2 and n = 3 are called double series and triple series, respectively. Cases with n>3 can be conceived but are not analysed here.

The electrical modelling of multiple-series connections in the AC regime is much more complex than the DC case, and yet to be fully developed. Here, we apply an approximate model due to Schurr et al. [28]. As can be seen from Figure 10, each coaxial wiring is modelled as a T network with series impedance Z_w (mainly due to the series resistance of the inner conductor, which can be relatively high – 1 Ω or greater – in cryogenic coaxial leads) and a parallel admittance Y_w (due to the cable capacitance and loss); a contact resistance R_c models the bonding and the device junctions.

The quantity of interest to be estimated is the relative deviation δZ_H caused by the connections

$$\delta Z_H = \frac{Z_H - R_H}{R_H}$$

where R_H is the quantized Hall resistance, and Z_H is the apparent two terminal-pair (2TP) impedance as seen by a measuring instrument at the extremes of the connections outside the cryostat.

The prediction of the model is

$$\delta Z_H = \left[\frac{Z_wY_w}{2} + \left(\frac{R_c + R_w}{R_H}\right)^n\right]^2$$

The quantities Z_w and Y_w can be estimated from the cable manufacturer specifications: in the following, the calculation is done for a 1.7 m long Lakeshore Ultra Miniature Coaxial Cable and a 0.3 m long RG58 coaxial cable. The quantity R_c is strongly dependent on the individual device employed in the experiment, and to some extent it can also vary for the same device in different cooling processes. We therefore computed the outcome of Equation 2 for two extreme cases, namely R_c = 10 mΩ and R_c = 10 Ω.

Table 1 summarizes the result of the calculations performed at the frequency f = 1541 Hz, which is of particular interest for the realisation of the farad unit from the quantized resistance [16]. It can be appreciated that, even for the case of a high contact resistance, a triple-series connection reduces the measurement error to about one part in 10⁸. The triple-series connection will be thus employed in the experiment. The residual error can be corrected if accurate measurements of the stray parameters are available.

5. CONCLUSIONS

The test shows that the probe can be employed to reach the quantization condition in Hall devices, and sensitive DC measurements can be performed.
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